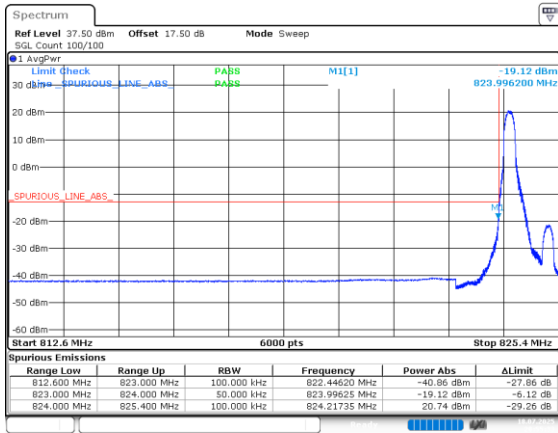


Out of band emission, Band Edge

FCC Part 22H & IC RSS 132

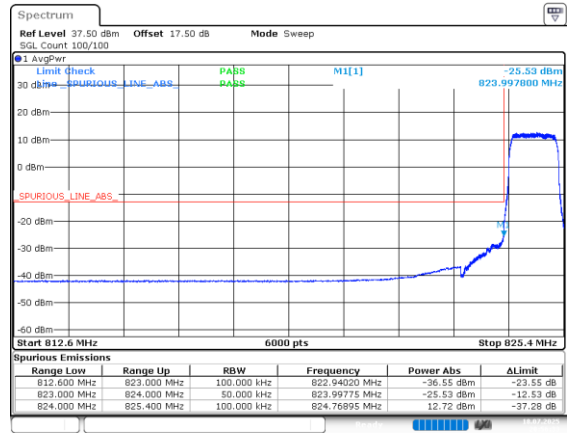
LTE Band 5, Normal

1.4MHz\_Low\_QPSK\_1@0



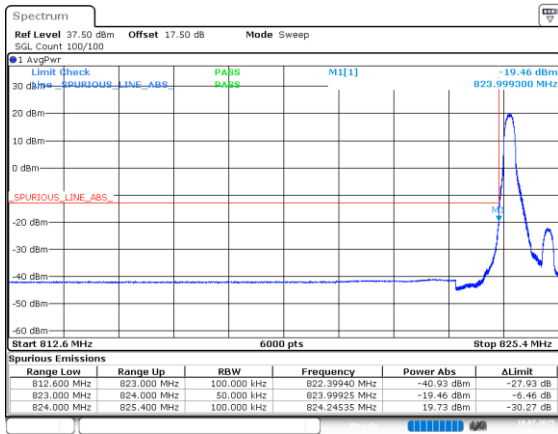
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18\_JUL\_2025 20:55:33

1.4MHz\_Low\_QPSK\_6@0



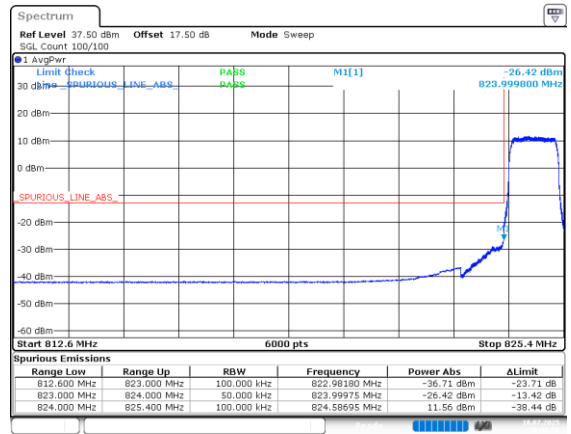
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Date: 18\_JUL\_2025 20:56:33

1.4MHz\_Low\_16QAM\_1@0



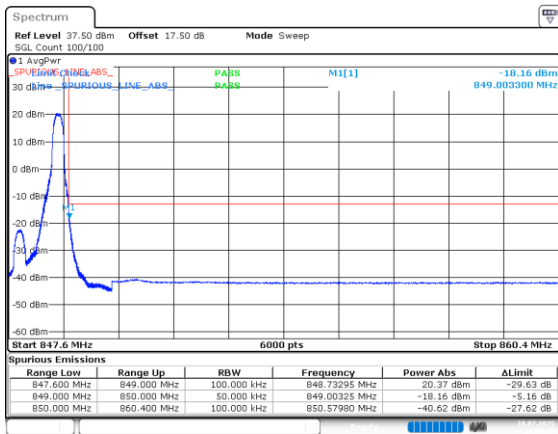
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Date: 18\_JUL\_2025 20:57:32

1.4MHz\_Low\_16QAM\_6@0



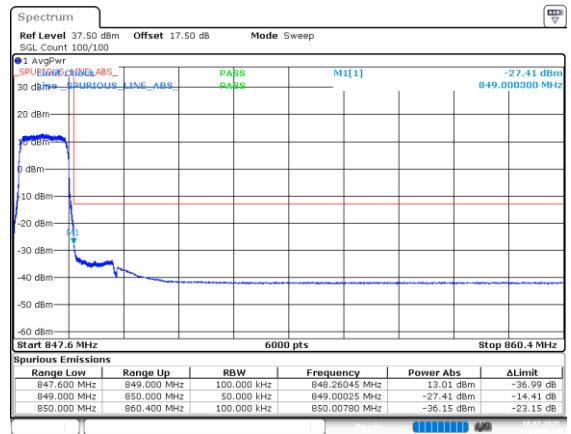
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18\_JUL\_2025 20:58:31

1.4MHz\_High\_QPSK\_1@5



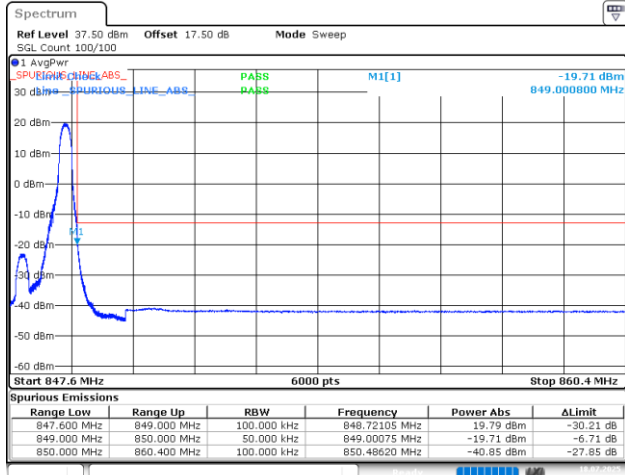
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18\_JUL\_2025 20:59:29

1.4MHz\_High\_QPSK\_6@0



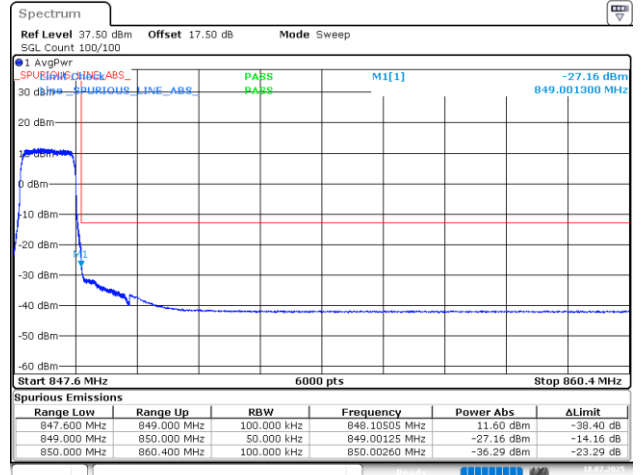
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18\_JUL\_2025 21:00:28

1.4MHz\_High\_16QAM\_1@5



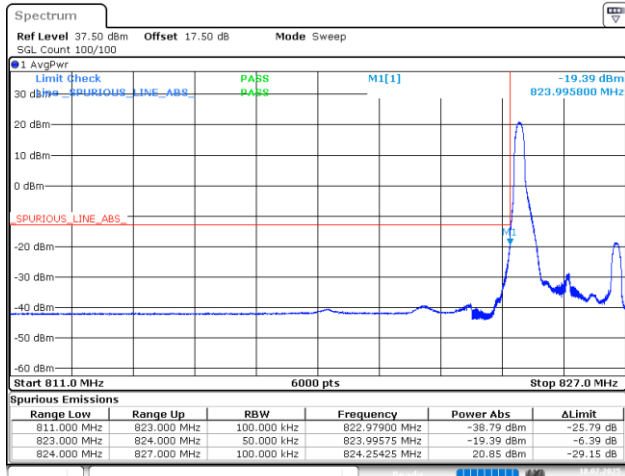
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:01:27

1.4MHz\_High\_16QAM\_6@0



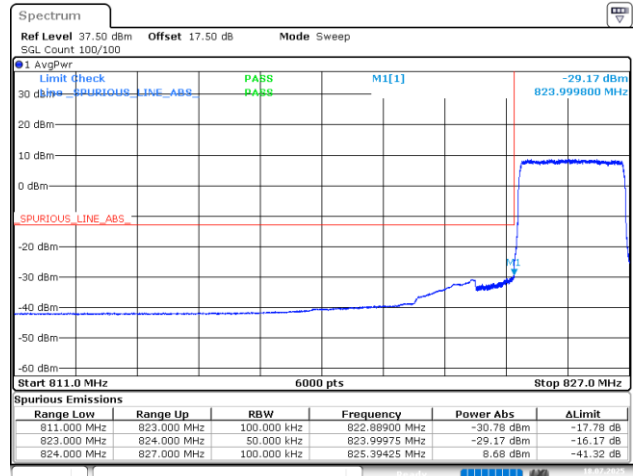
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:02:27

3MHz\_Low\_QPSK\_1@0



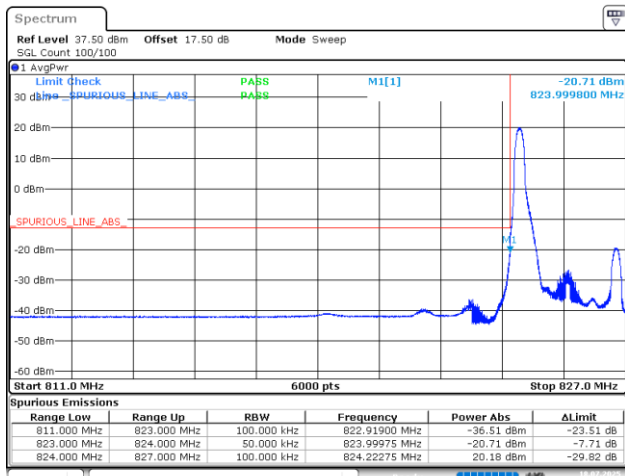
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:05:04

3MHz\_Low\_QPSK\_15@0



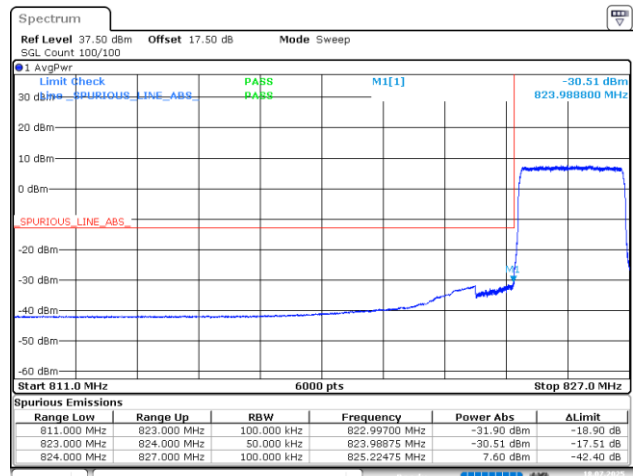
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:06:15

3MHz\_Low\_16QAM\_1@0



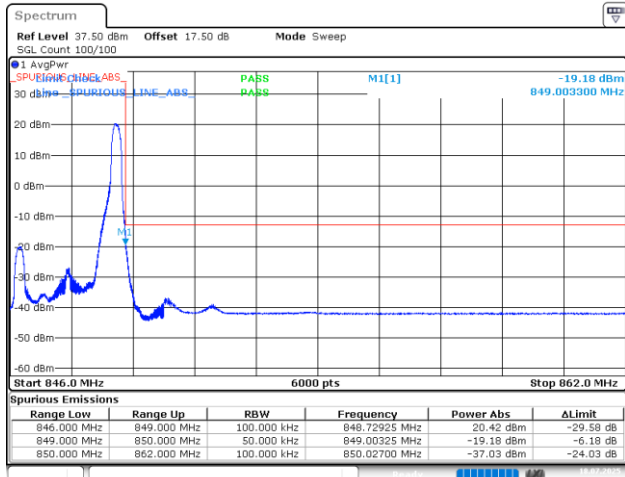
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Date: 18.JUL.2025 21:07:24

3MHz\_Low\_16QAM\_15@0



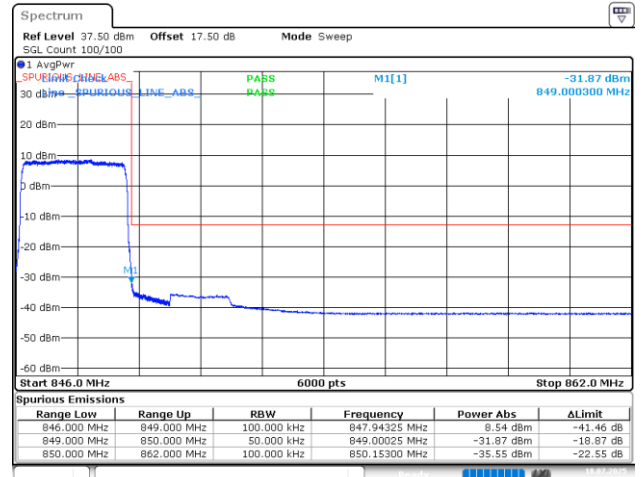
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Date: 18.JUL.2025 21:08:34

3MHz\_High\_QPSK\_1@14



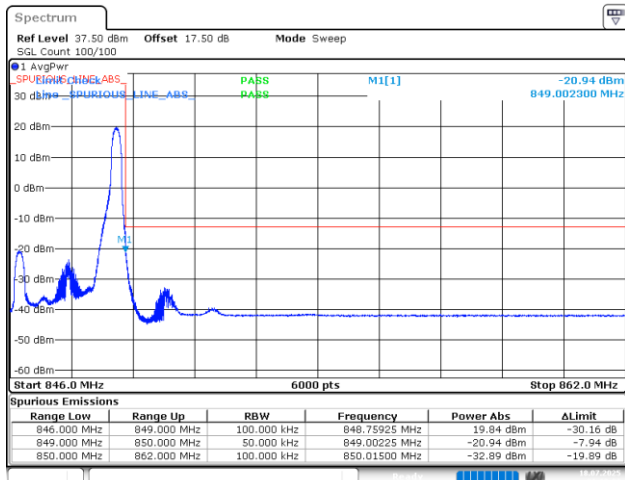
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Date: 18.JUL.2025 21:09:43

3MHz\_High\_QPSK\_15@0



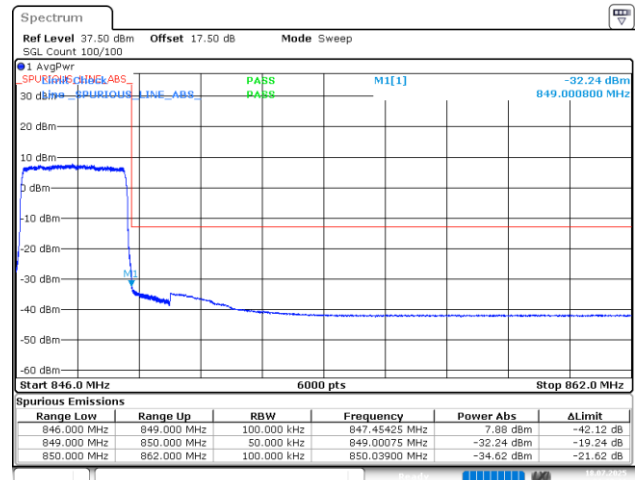
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Date: 18.JUL.2025 21:10:53

3MHz\_High\_16QAM\_1@14



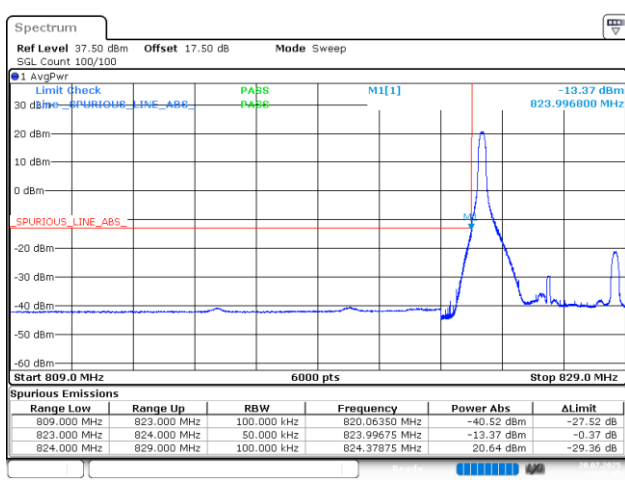
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:12:02

3MHz\_High\_16QAM\_15@0



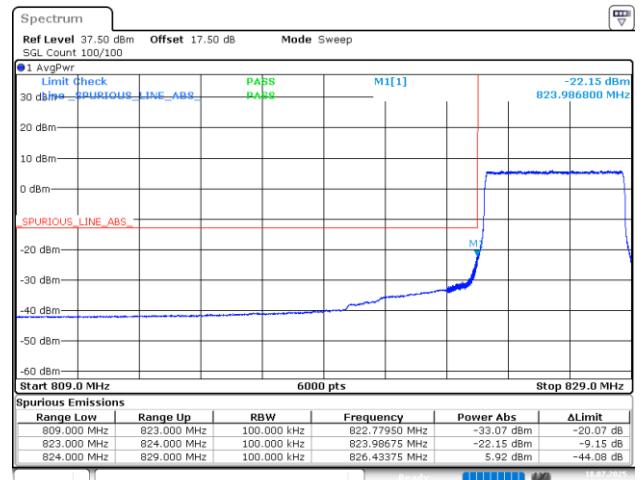
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Date: 18.JUL.2025 21:13:11

5MHz\_Low\_QPSK\_1@0



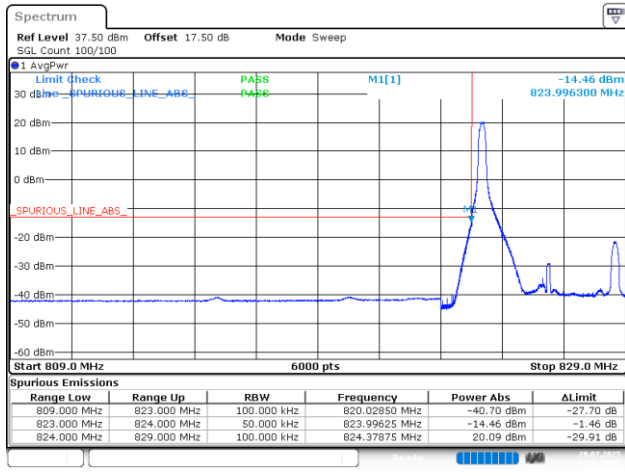
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Date: 20.JUL.2025 14:55:02

5MHz\_Low\_QPSK\_25@0



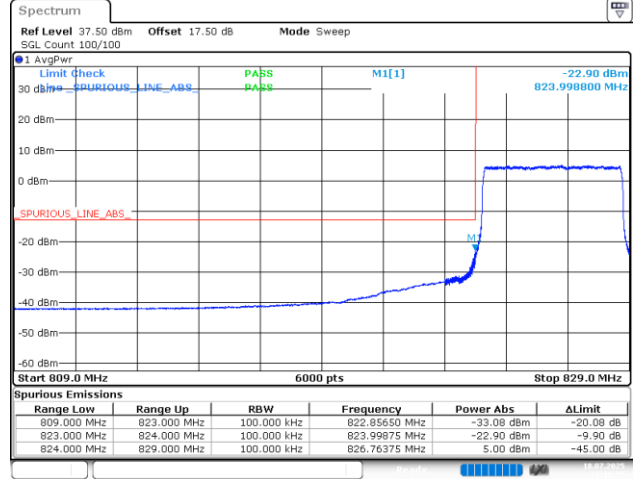
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Date: 18.JUL.2025 21:16:40

5MHz\_Low\_16QAM\_1@0



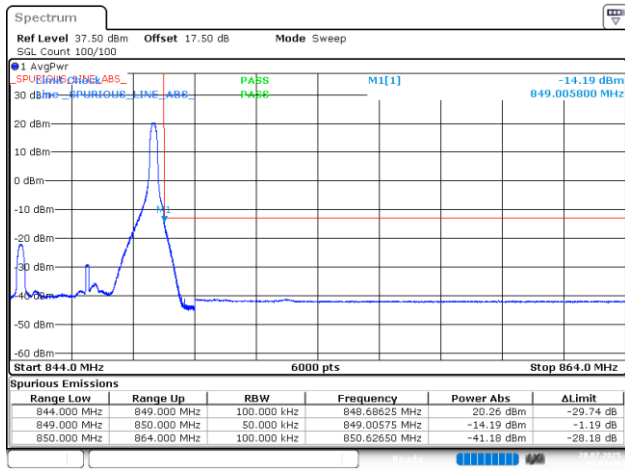
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Date: 20.JUL.2025 14:59:07

5MHz\_Low\_16QAM\_25@0



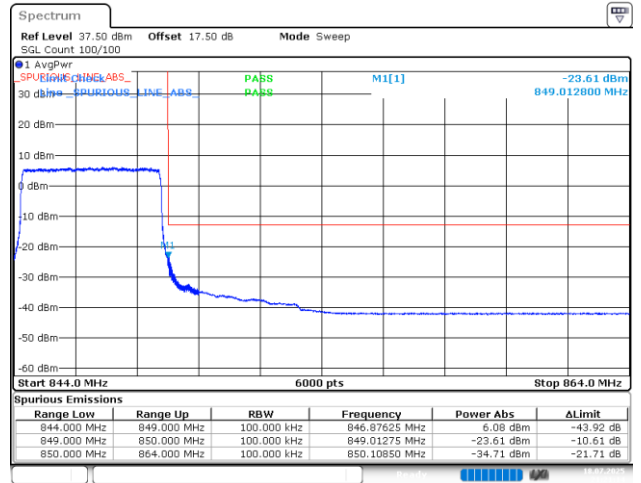
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5MHz\_High\_QPSK\_1@24



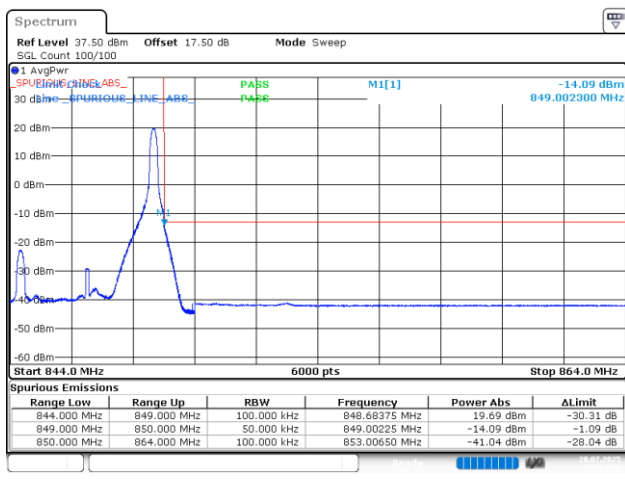
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5MHz\_High\_QPSK\_25@0



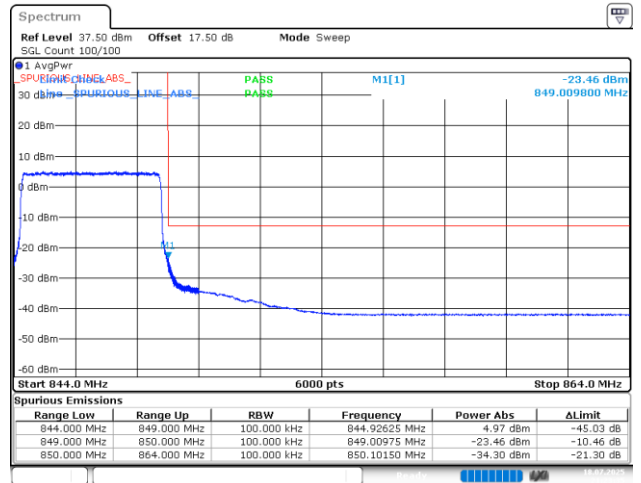
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5MHz\_High\_16QAM\_1@24



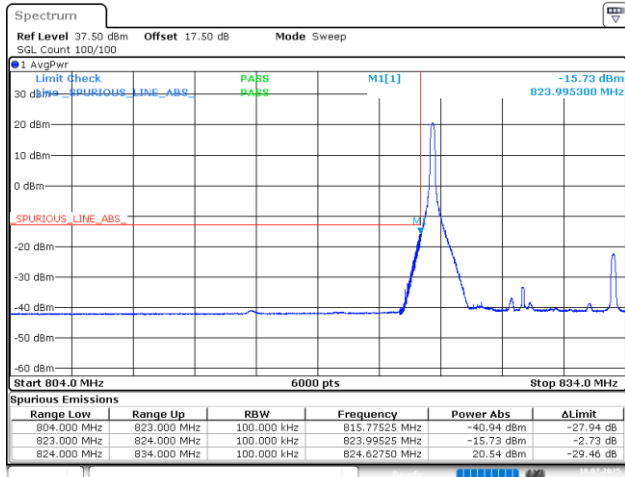
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5MHz\_High\_16QAM\_25@0



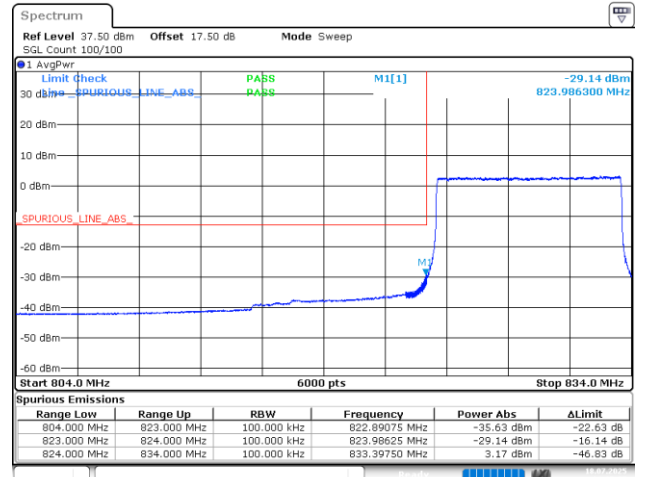
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:23:35

10MHz\_Low\_QPSK\_1@0



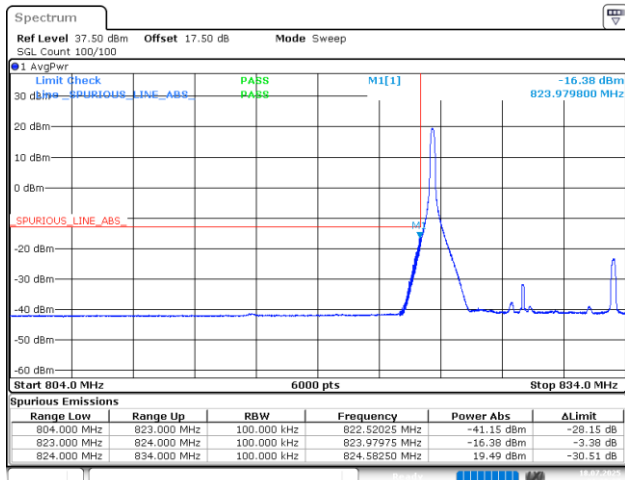
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:26:23

10MHz\_Low\_QPSK\_50@0



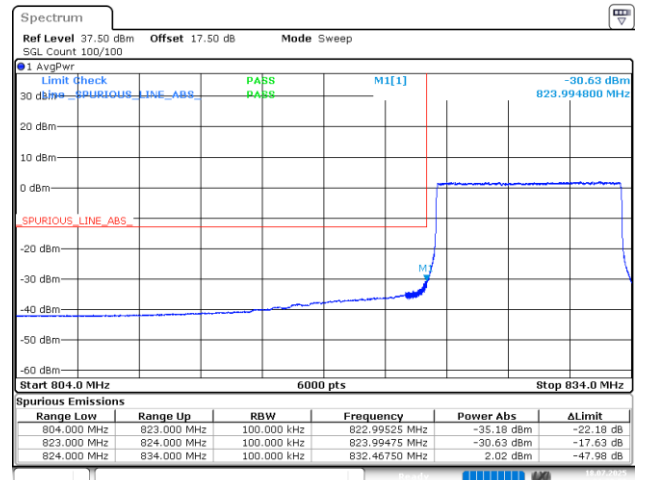
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Date: 18.JUL.2025 21:27:55

10MHz\_Low\_16QAM\_1@0



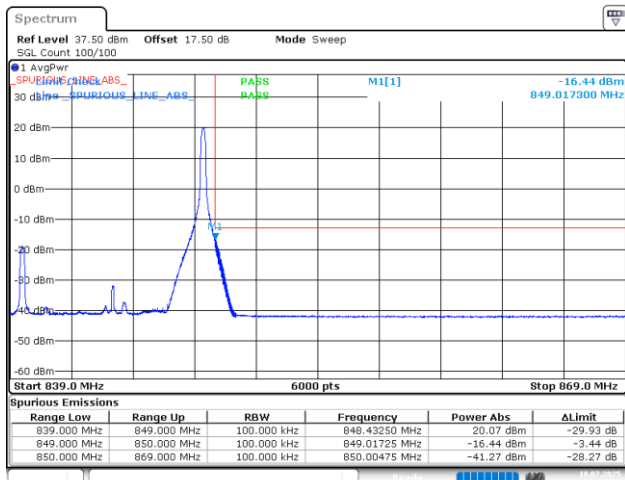
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Date: 18.JUL.2025 21:29:27

10MHz\_Low\_16QAM\_50@0



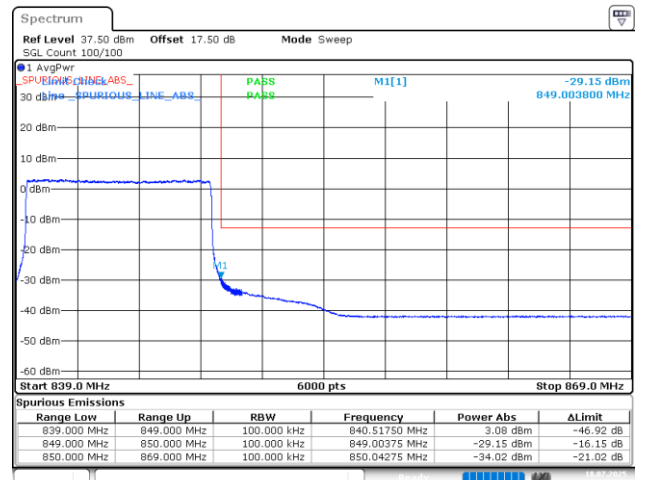
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Date: 18.JUL.2025 21:30:59

10MHz\_High\_QPSK\_1@49



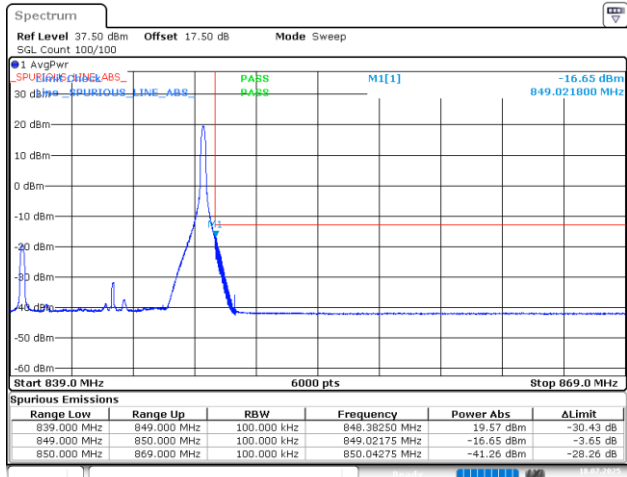
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Date: 18.JUL.2025 21:32:30

10MHz\_High\_QPSK\_50@0



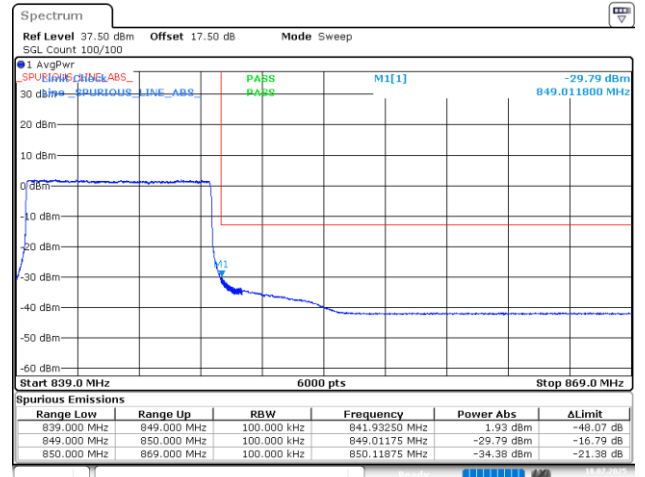
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:34:00

10MHz\_High\_16QAM\_1@49



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:35:31

10MHz\_High\_16QAM\_50@0

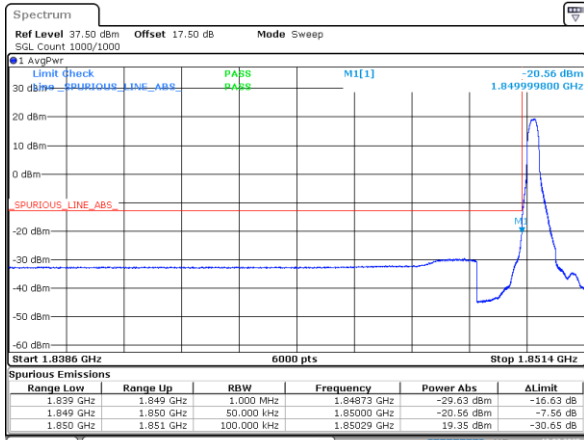


ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 21:37:01

FCC Part 24E & IC RSS 133

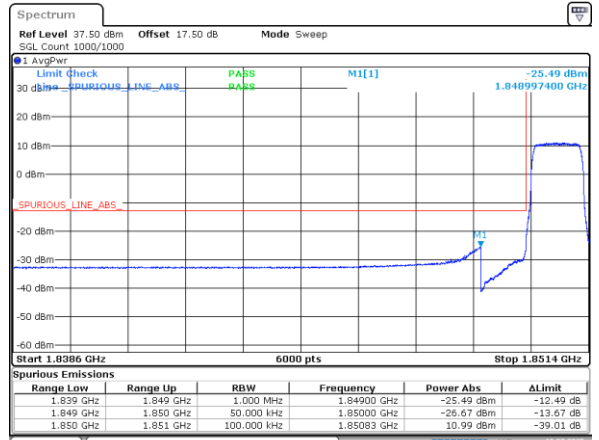
LTE Band 2, Normal

1.4MHz\_Low\_QPSK\_1@0



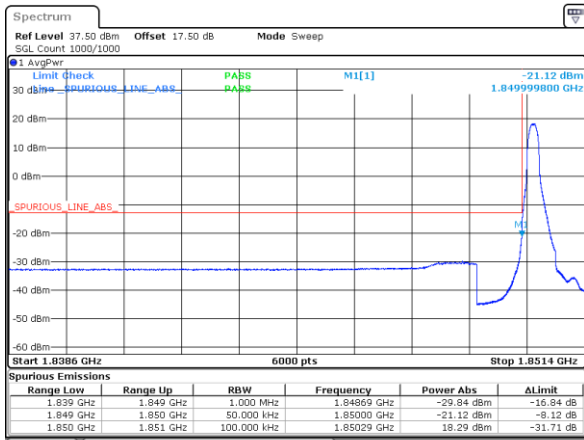
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 12:00:48

1.4MHz\_Low\_QPSK\_6@0



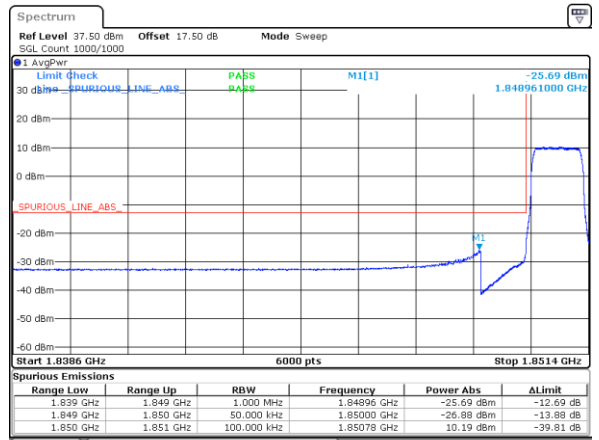
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Date: 18.JUL.2025 12:03:20

1.4MHz\_Low\_16QAM\_1@0



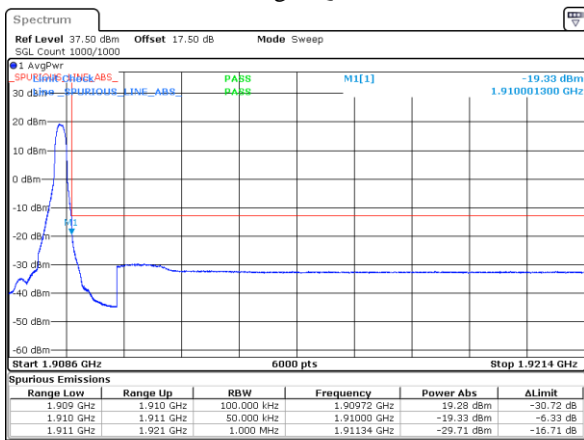
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 12:05:50

1.4MHz\_Low\_16QAM\_6@0



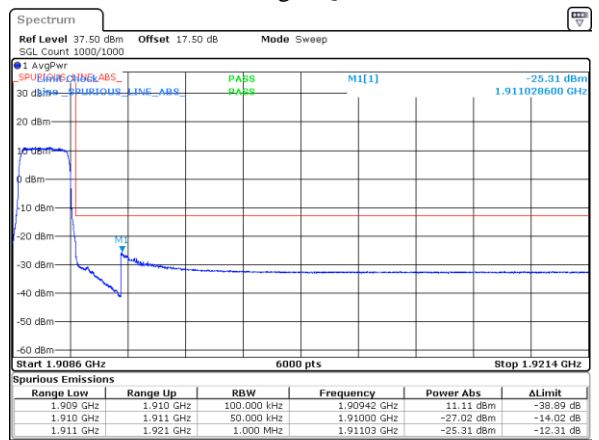
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Date: 18.JUL.2025 12:08:20

1.4MHz\_High\_QPSK\_1@5



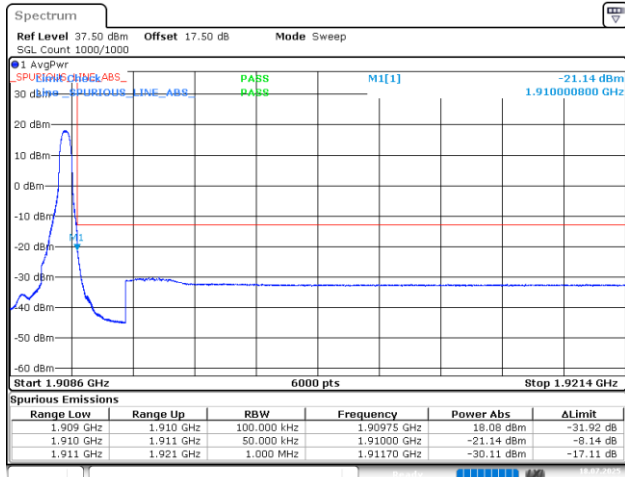
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 12:10:51

1.4MHz\_High\_QPSK\_6@0



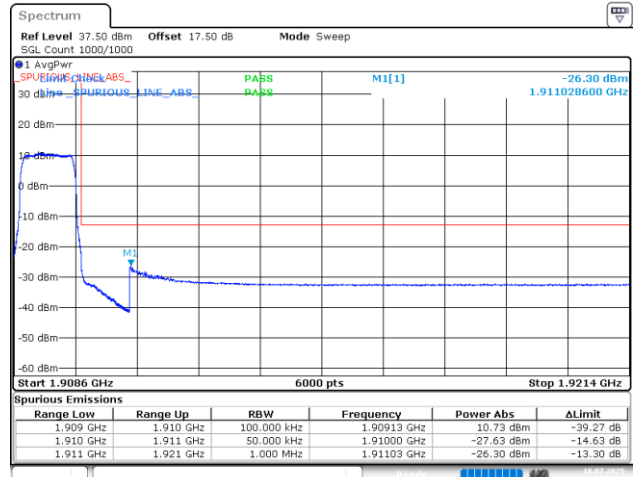
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Date: 18.JUL.2025 12:13:22

1.4MHz\_High\_16QAM\_1@5



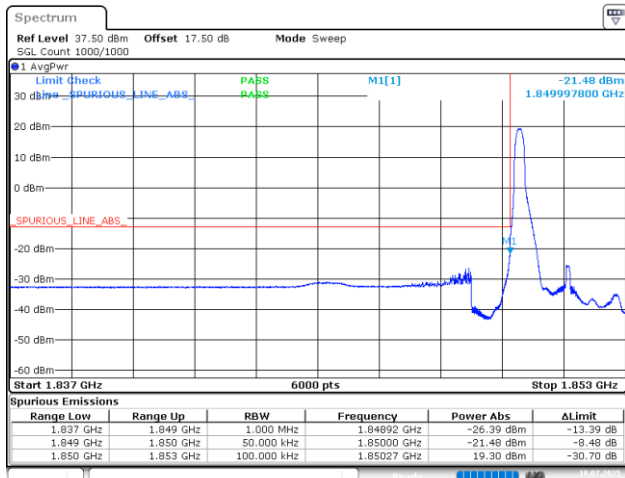
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Date: 18.JUL.2025 12:15:54

1.4MHz\_High\_16QAM\_6@0



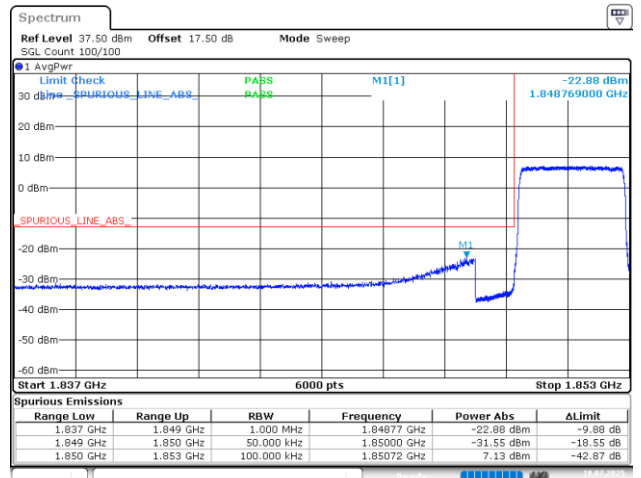
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:25:07

3MHz\_Low\_QPSK\_1@0



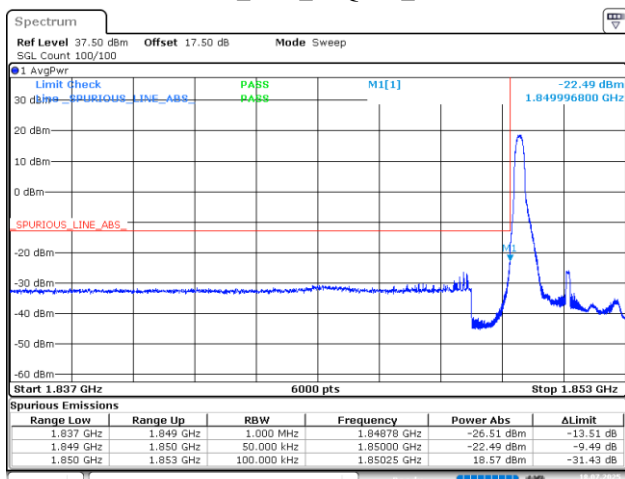
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:29:19

3MHz\_Low\_QPSK\_15@0



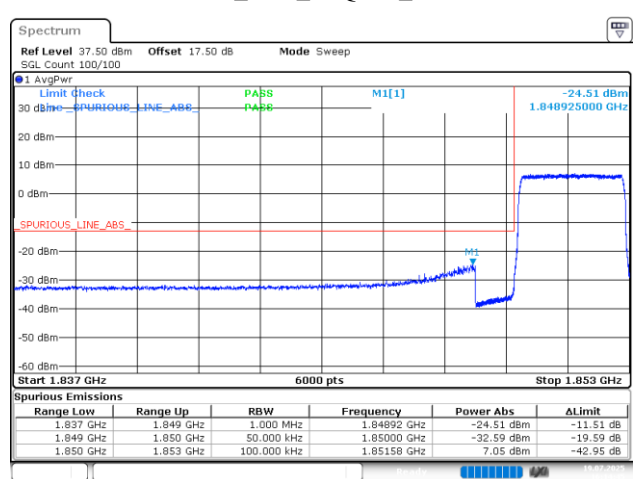
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:36:14

3MHz\_Low\_16QAM\_1@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:36:50

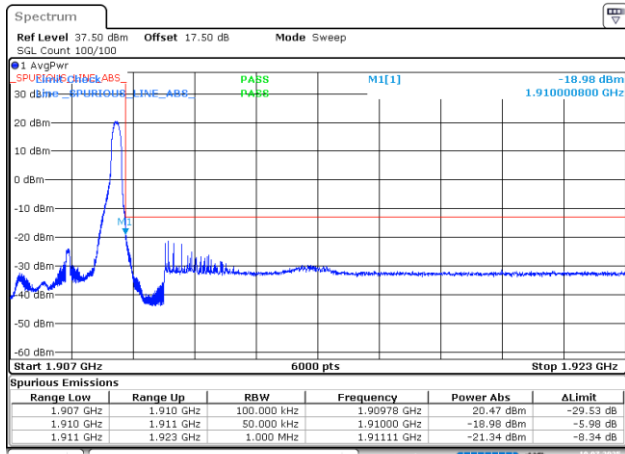
3MHz\_Low\_16QAM\_15@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 16:14:45

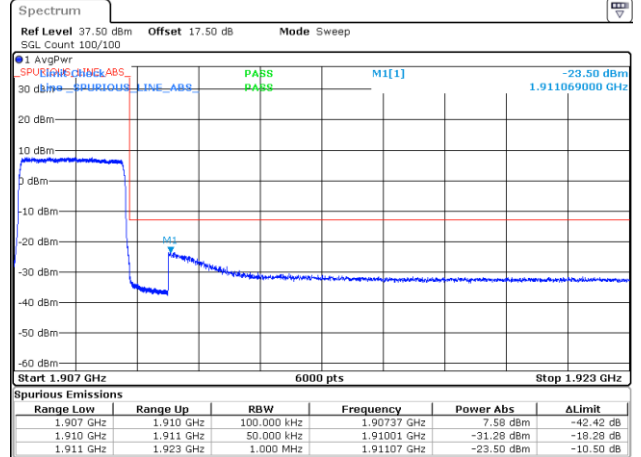


3MHz\_High\_QPSK\_1@14



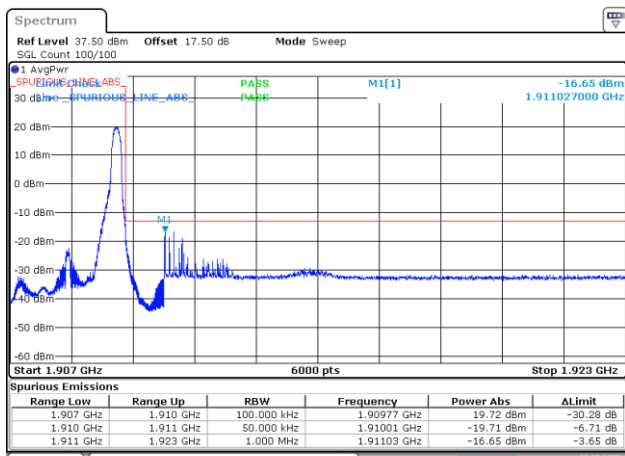
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Date: 19.JUL.2025 16:15:18

3MHz\_High\_QPSK\_15@0



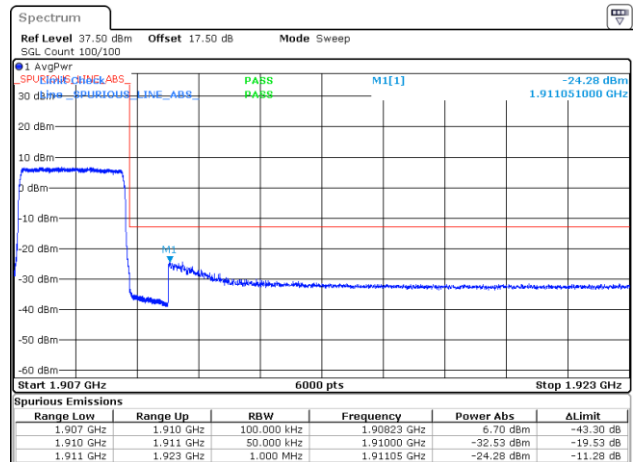
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:38:43

3MHz\_High\_16QAM\_1@14



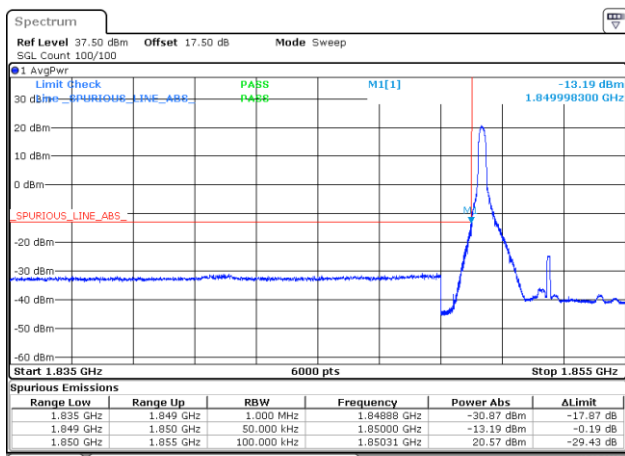
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 16:15:51

3MHz\_High\_16QAM\_15@0



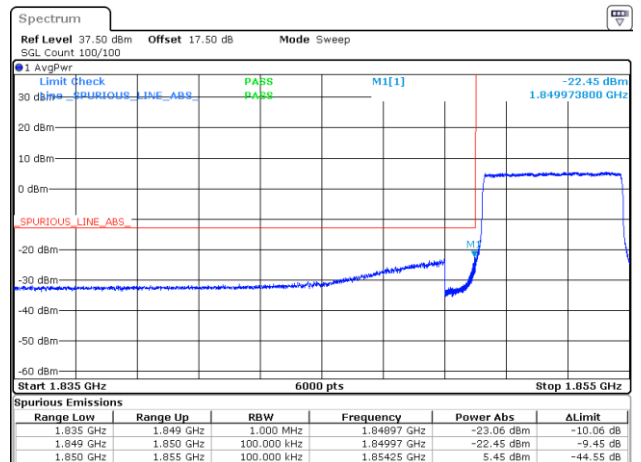
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:39:58

5MHz\_Low\_QPSK\_1@0



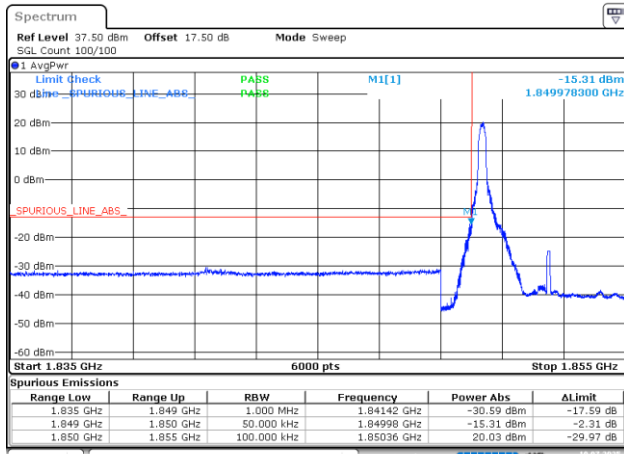
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 18:20:57

5MHz\_Low\_QPSK\_25@0



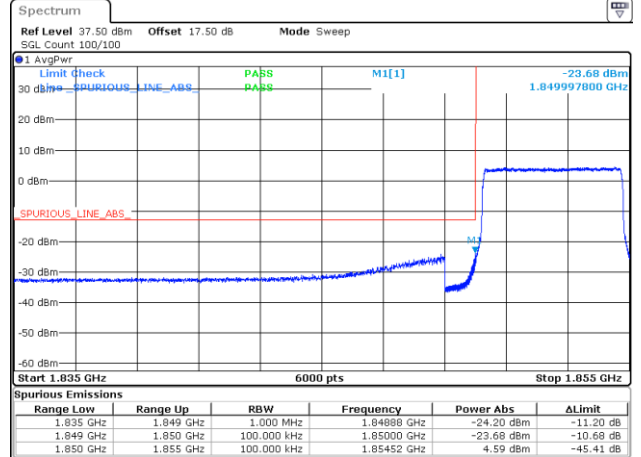
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:42:45

5MHz\_Low\_16QAM\_1@0



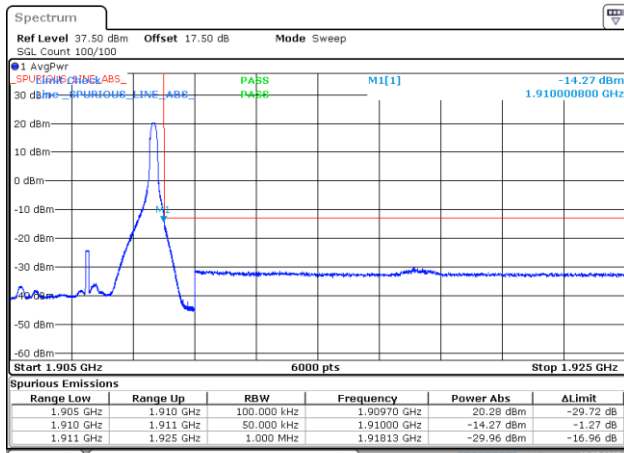
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 18:22:12

5MHz\_Low\_16QAM\_25@0



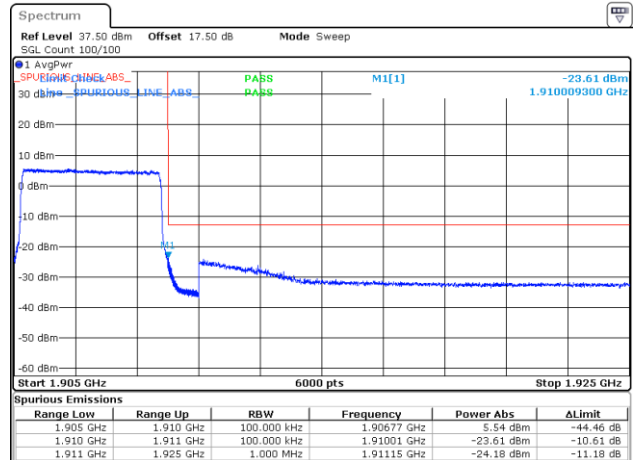
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 19:43:55

5MHz\_High\_QPSK\_1@24



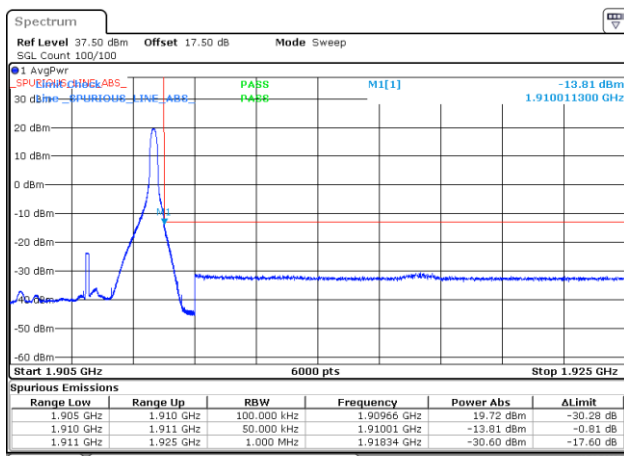
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Date: 19.JUL.2025 18:23:18

5MHz\_High\_QPSK\_25@0



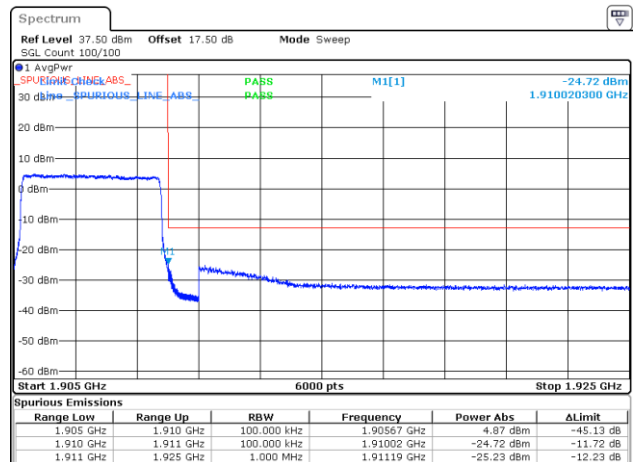
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Date: 19.JUL.2025 19:45:06

5MHz\_High\_16QAM\_1@24



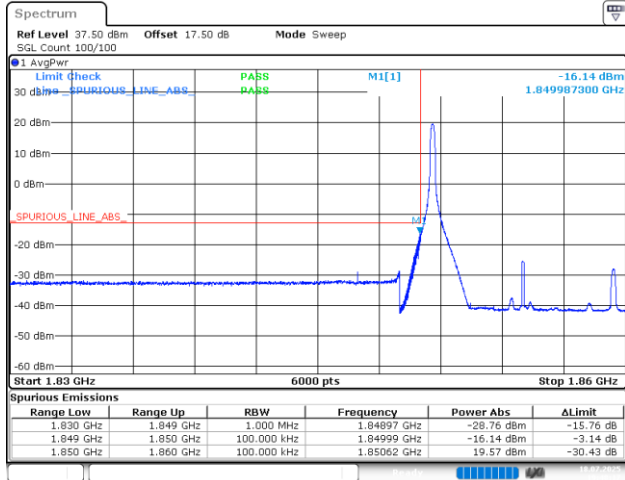
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Date: 19.JUL.2025 18:24:24

5MHz\_High\_16QAM\_25@0



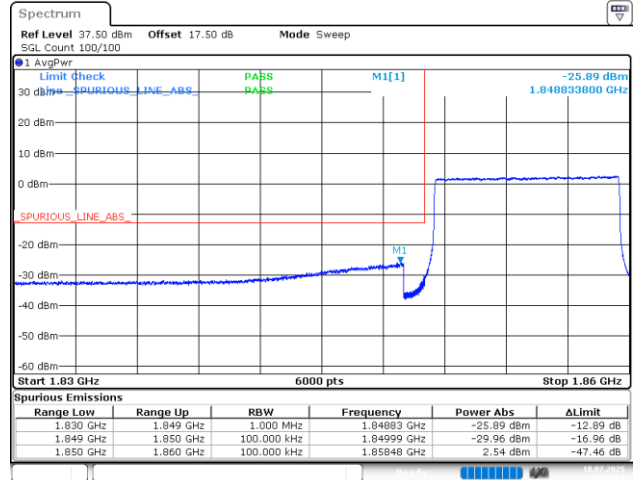
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 19.JUL.2025 19:46:15

10MHz\_Low\_QPSK\_1@0



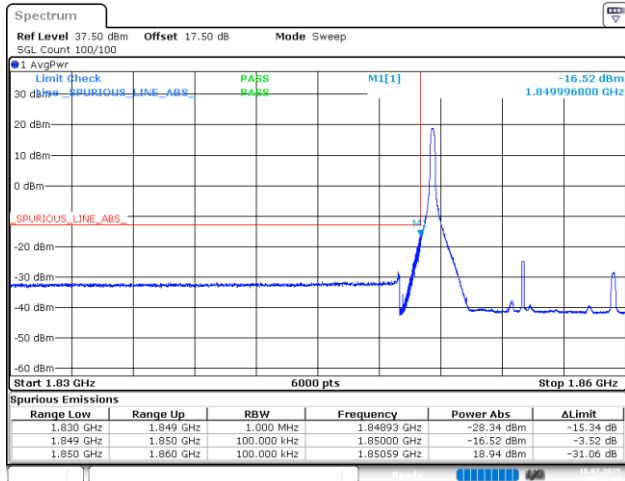
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:48:17

10MHz\_Low\_QPSK\_50@0



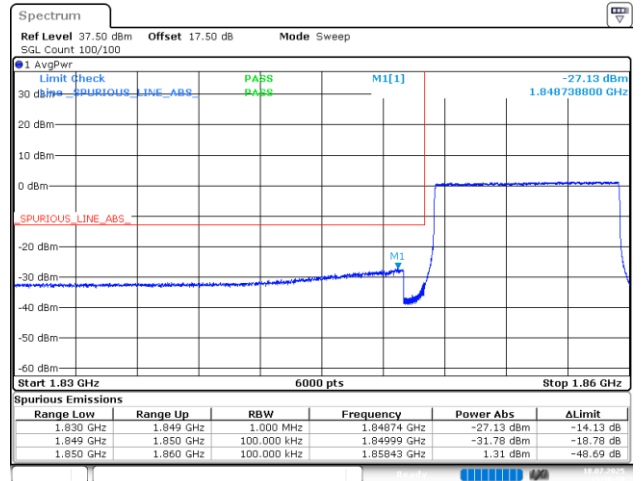
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:49:04

10MHz\_Low\_16QAM\_1@0



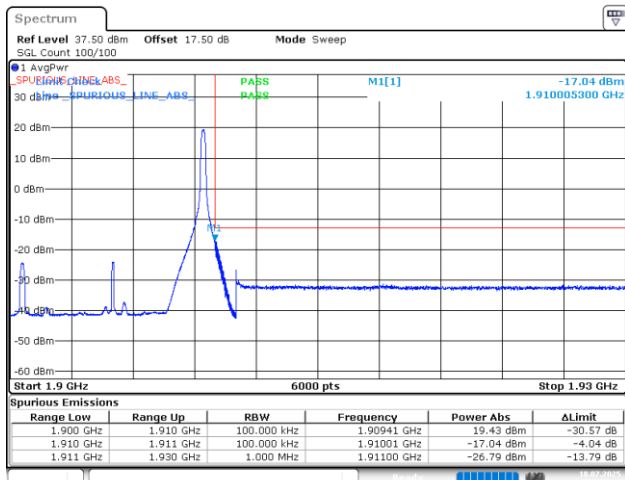
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:49:51

10MHz\_Low\_16QAM\_50@0



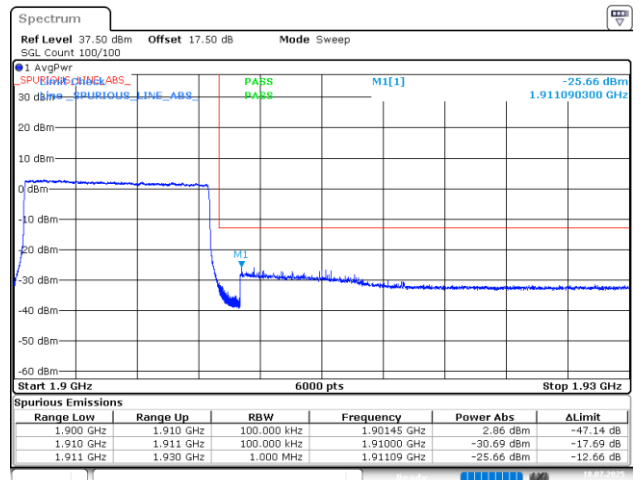
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:50:38

10MHz\_High\_QPSK\_1@49



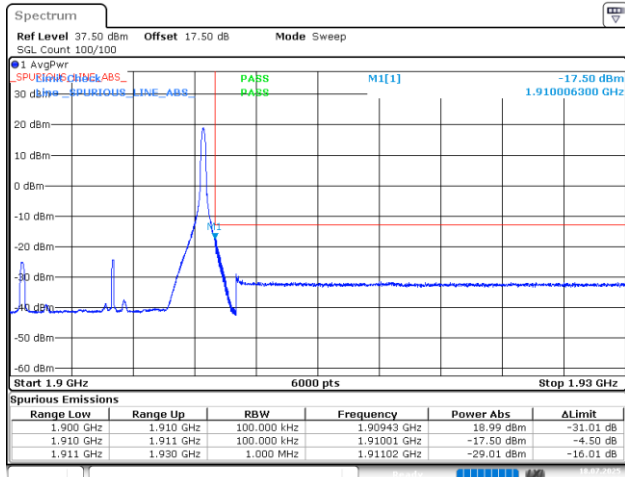
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Date: 18.JUL.2025 19:51:23

10MHz\_High\_QPSK\_50@0



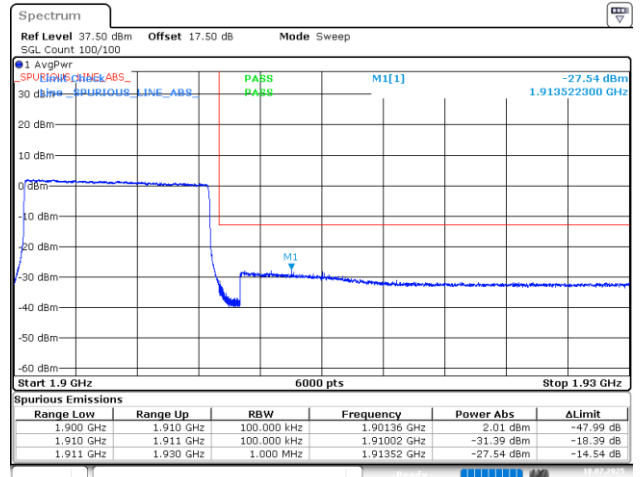
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10MHz\_High\_16QAM\_1@49



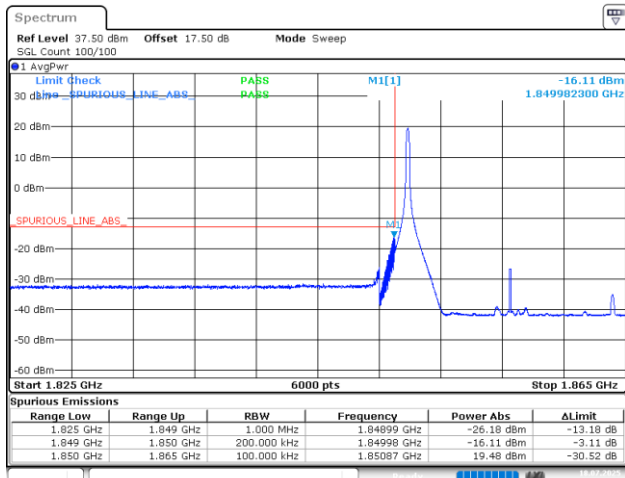
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Date: 18.JUL.2025 19:52:54

10MHz\_High\_16QAM\_50@0



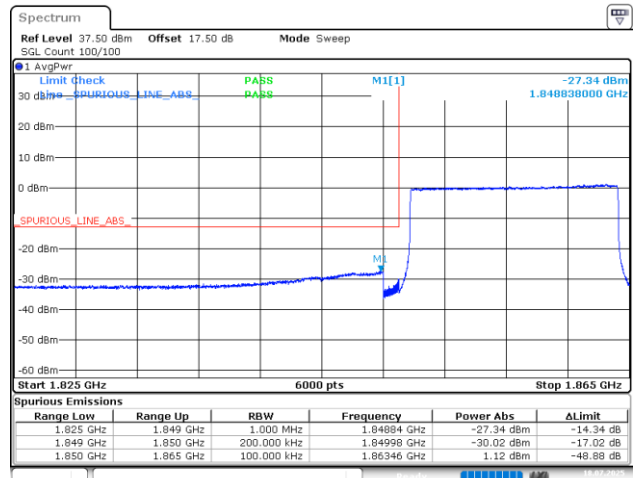
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15MHz\_Low\_QPSK\_1@0



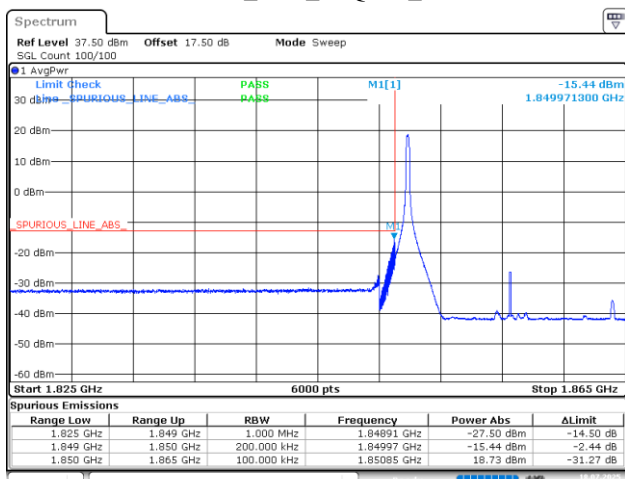
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15MHz\_Low\_QPSK\_75@0



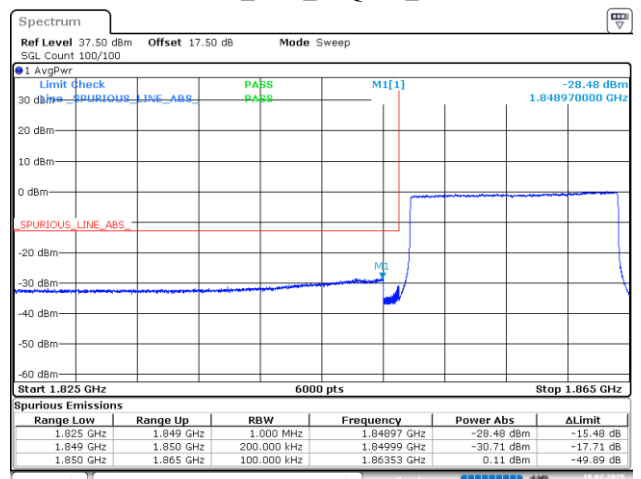
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15MHz\_Low\_16QAM\_1@0



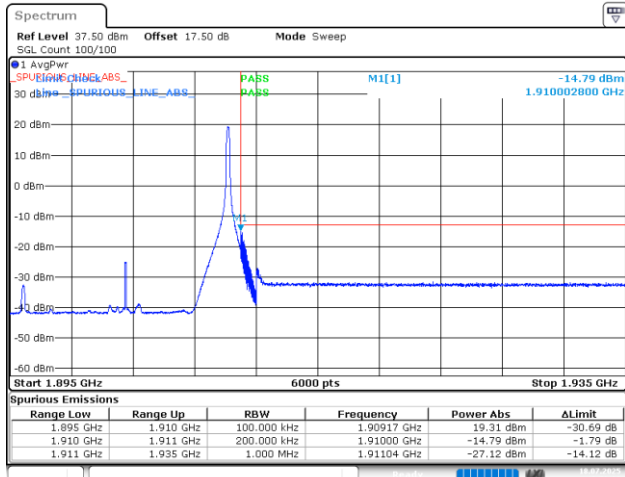
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15MHz\_Low\_16QAM\_75@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 19:58:43

15MHz\_High\_QPSK\_1@74



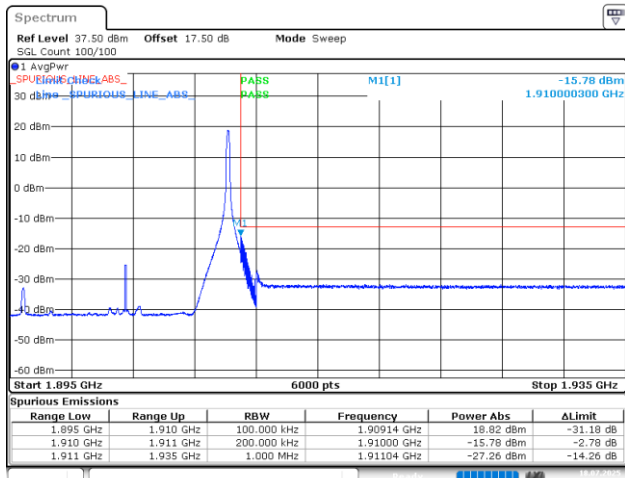
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15MHz\_High\_QPSK\_75@0



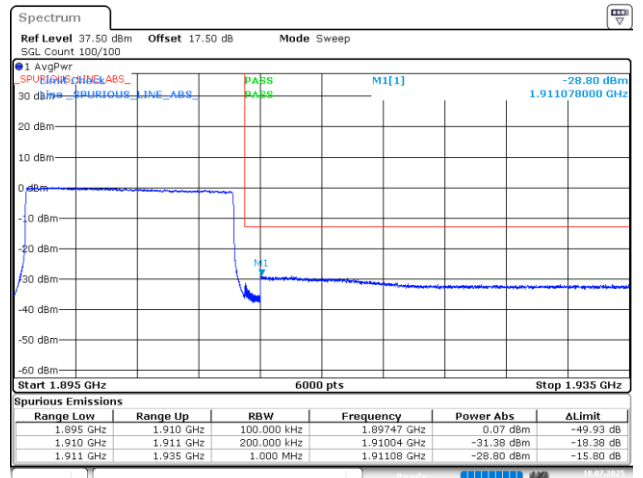
ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 20:00:34

15MHz\_High\_16QAM\_1@74



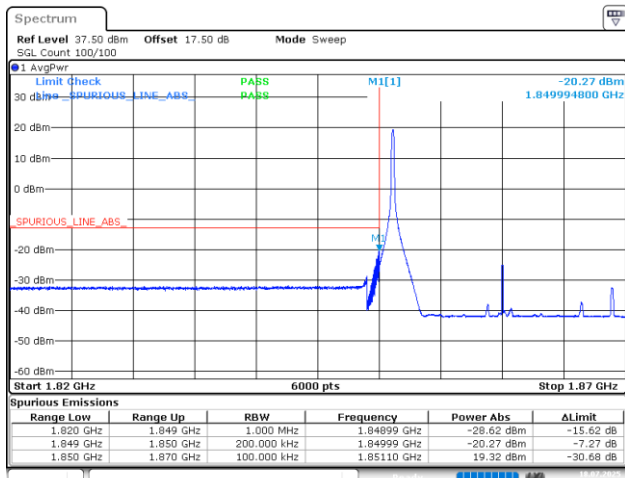
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15MHz\_High\_16QAM\_75@0



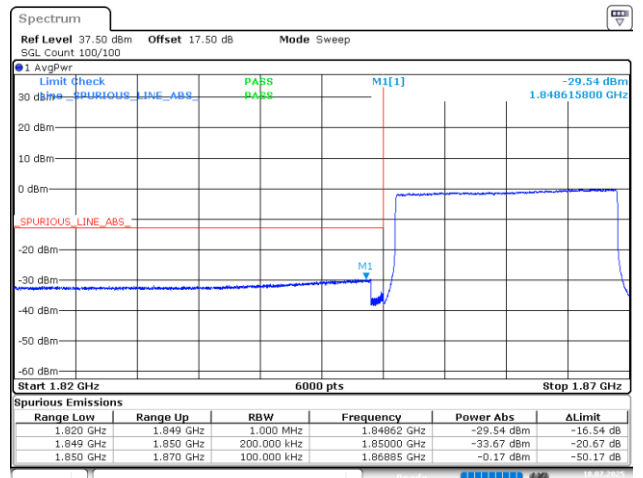
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Date: 18.JUL.2025 20:02:25

20MHz\_Low\_QPSK\_1@0



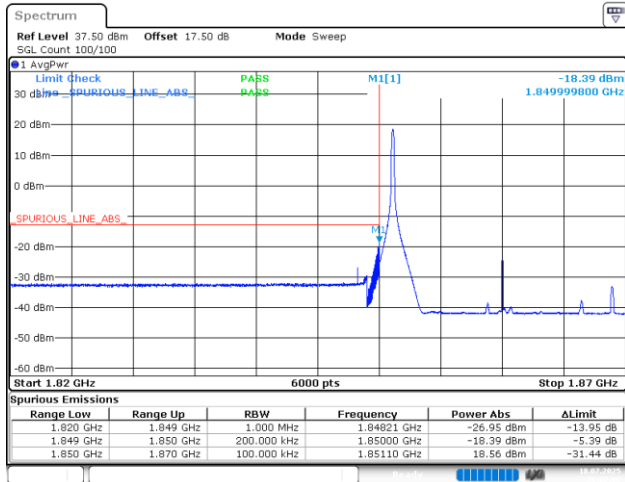
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Date: 18.JUL.2025 20:04:54

20MHz\_Low\_QPSK\_100@0



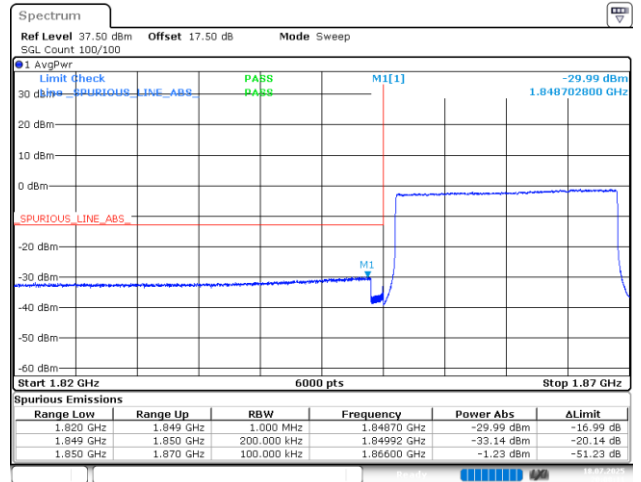
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Date: 18.JUL.2025 20:06:00

20MHz\_Low\_16QAM\_1@0



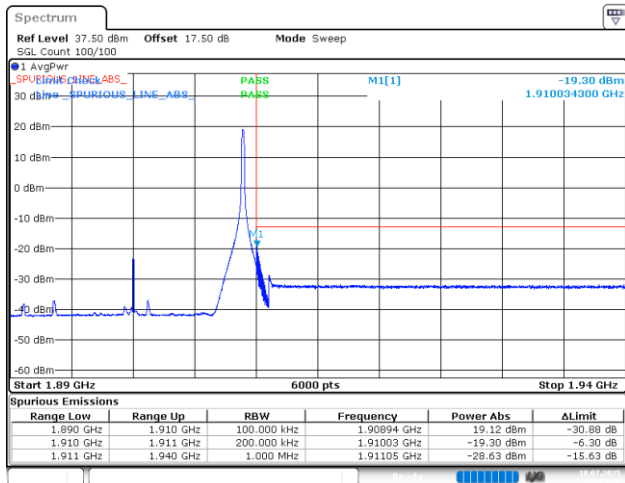
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20MHz\_Low\_16QAM\_100@0



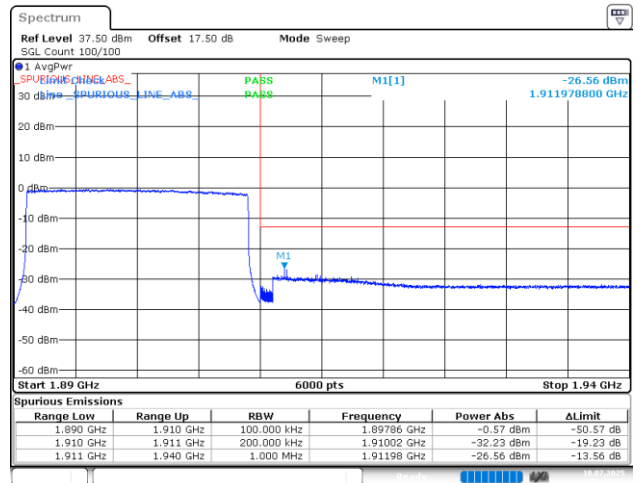
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Date: 18.JUL.2025 20:08:11

20MHz\_High\_QPSK\_1@99



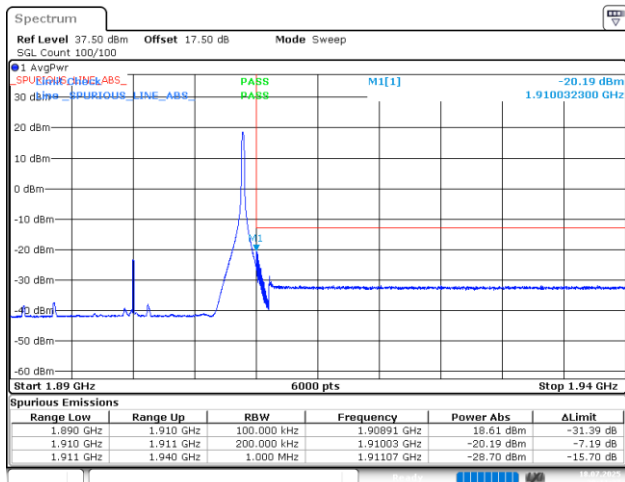
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20MHz\_High\_QPSK\_100@0



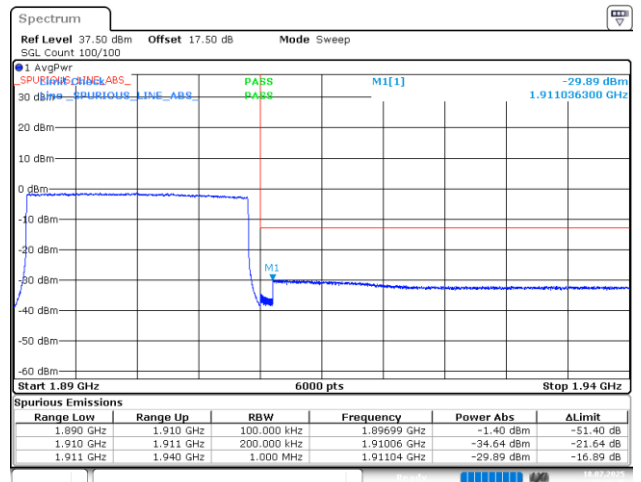
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Date: 18.JUL.2025 20:10:29

20MHz\_High\_16QAM\_1@99



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 20:11:37

20MHz\_High\_16QAM\_100@0

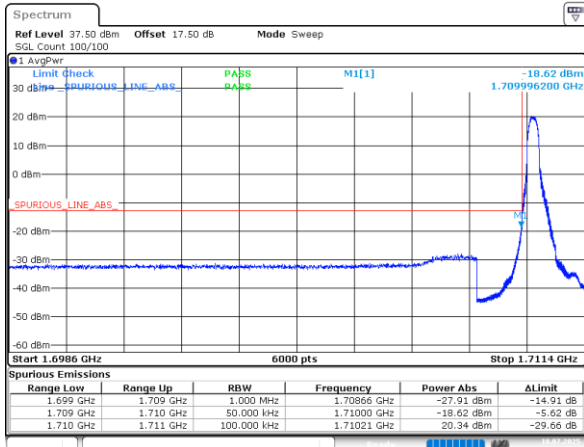


ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 20:12:45

FCC Part 27 & IC RSS 139

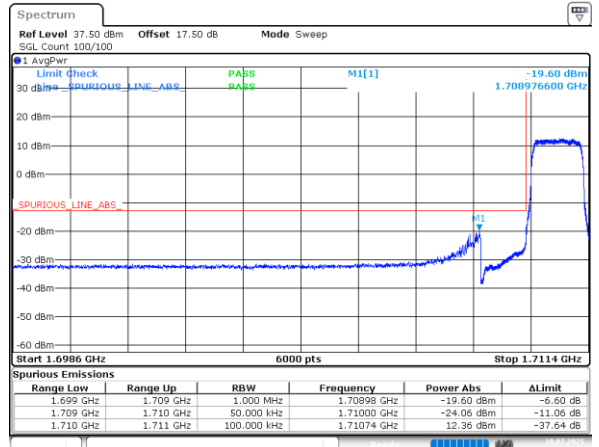
LTE Band 4, Normal

1.4MHz\_Low\_QPSK\_1@0



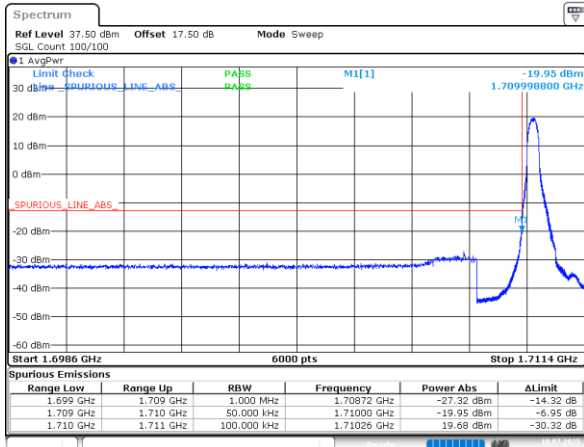
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1.4MHz\_Low\_QPSK\_6@0



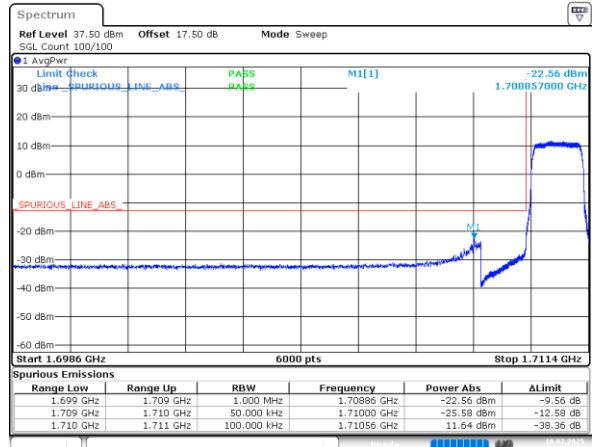
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1.4MHz\_Low\_16QAM\_1@0



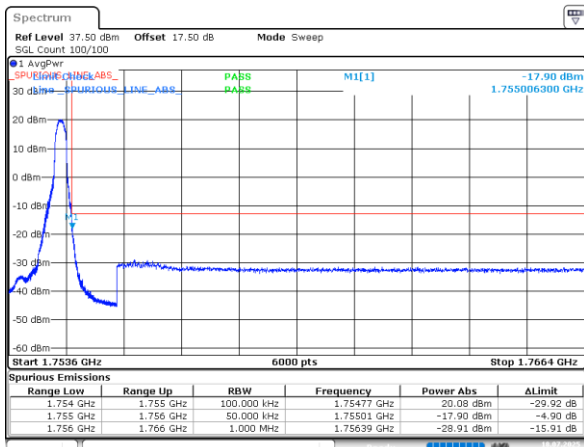
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1.4MHz\_Low\_16QAM\_6@0



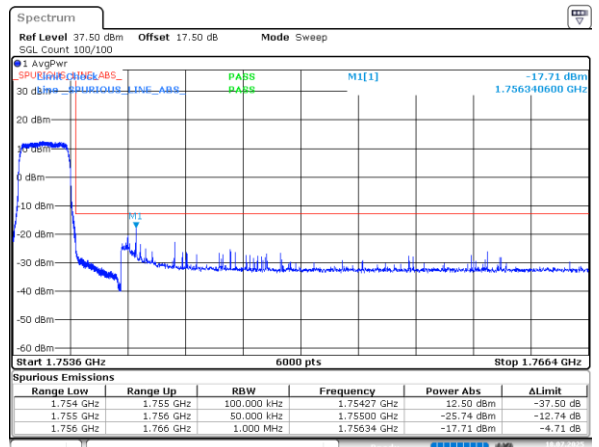
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1.4MHz\_High\_QPSK\_1@5



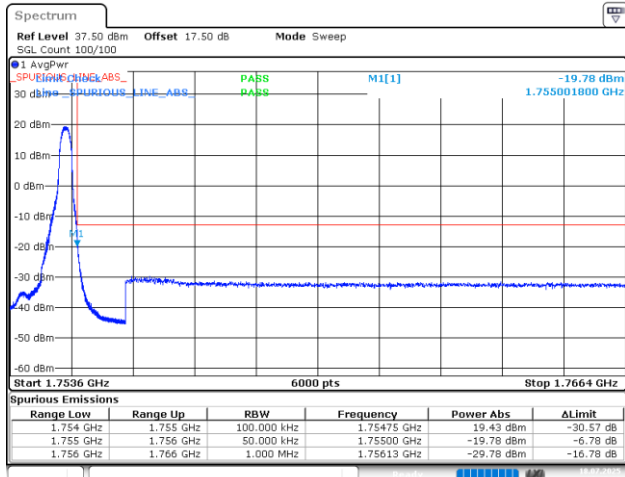
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Date: 18.JUL.2025 20:16:01

1.4MHz\_High\_QPSK\_6@0



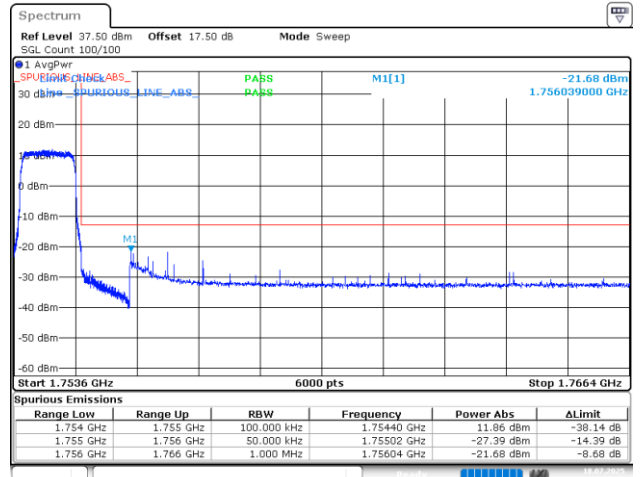
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1.4MHz\_High\_16QAM\_1@5



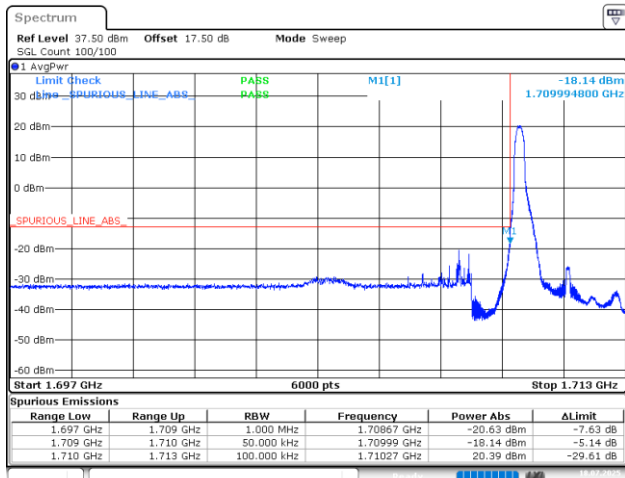
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1.4MHz\_High\_16QAM\_6@0



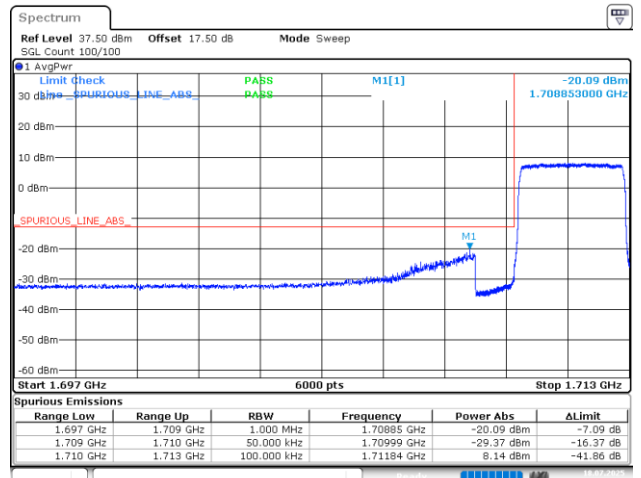
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3MHz\_Low\_QPSK\_1@0



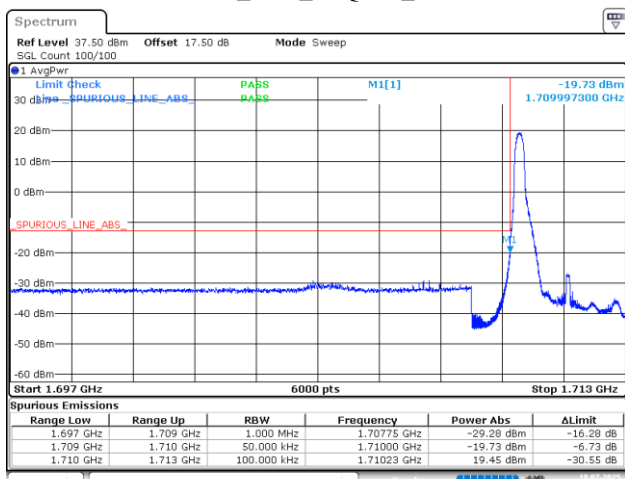
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Date: 18.JUL.2025 20:18:54

3MHz\_Low\_QPSK\_15@0



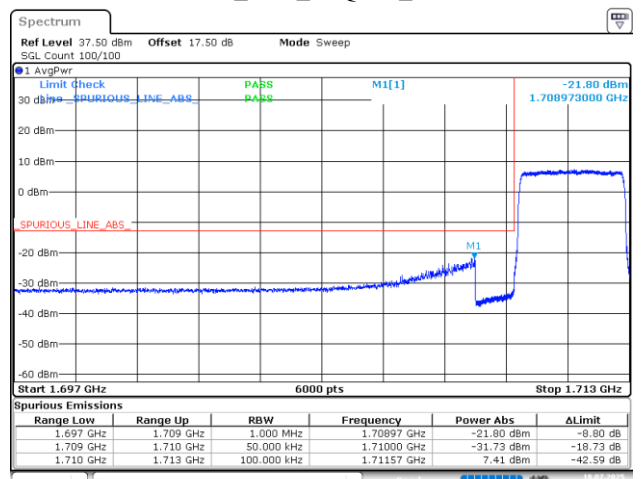
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Date: 18.JUL.2025 20:19:33

3MHz\_Low\_16QAM\_1@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 20:20:13

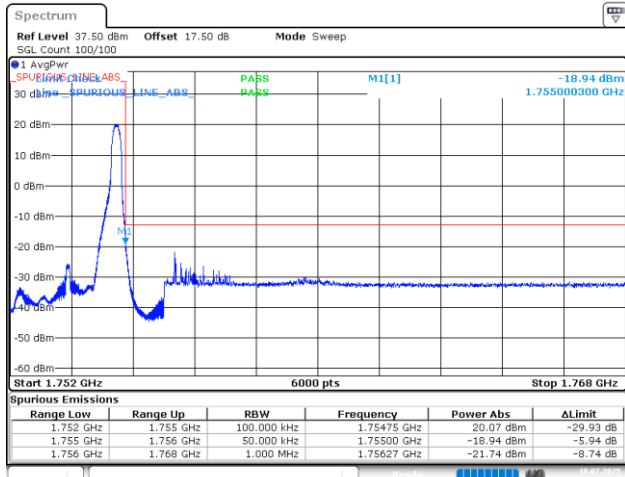
3MHz\_Low\_16QAM\_15@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 18.JUL.2025 20:20:52

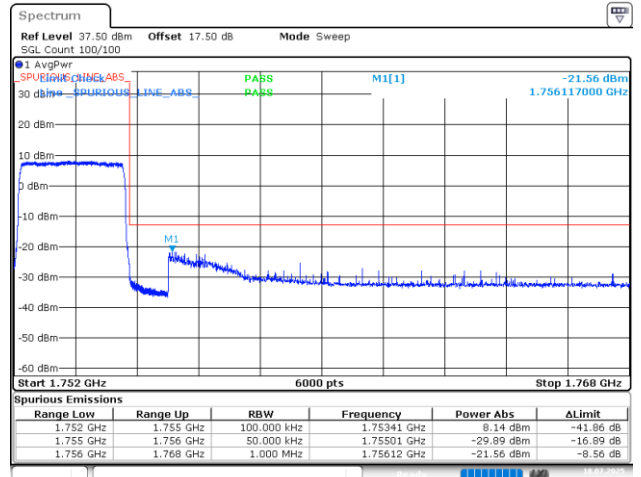


3MHz\_High\_QPSK\_1@14



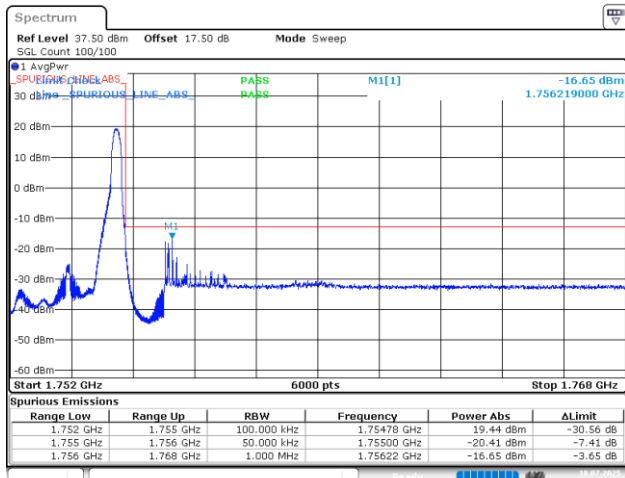
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3MHz\_High\_QPSK\_15@0



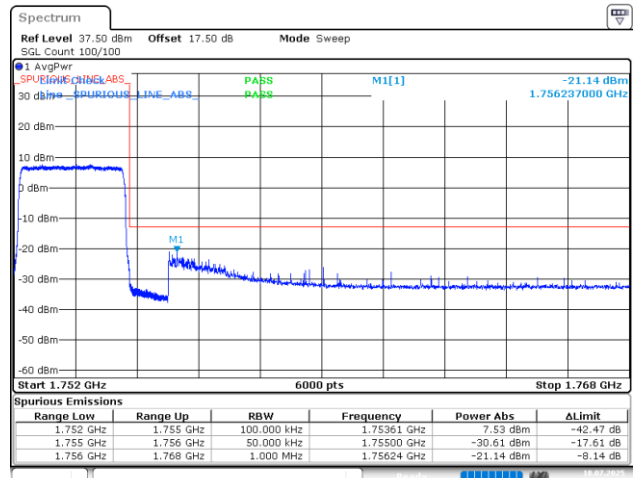
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3MHz\_High\_16QAM\_1@14



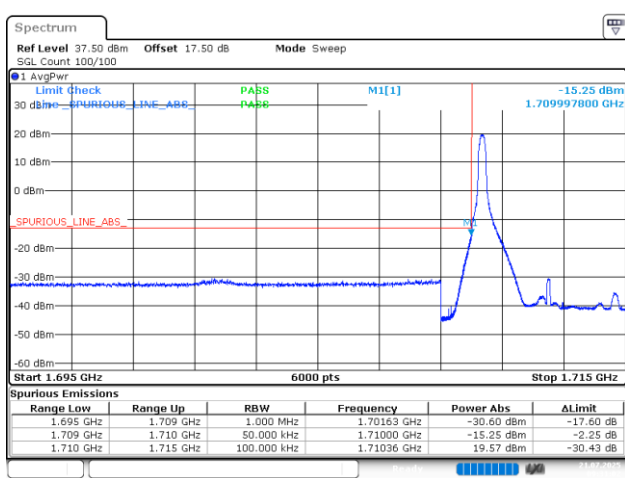
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3MHz\_High\_16QAM\_15@0



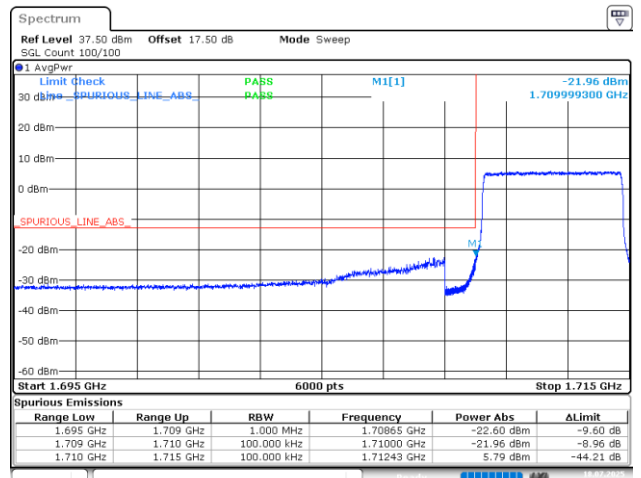
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Date: 18.JUL.2025 20:23:31

5MHz\_Low\_QPSK\_1@0



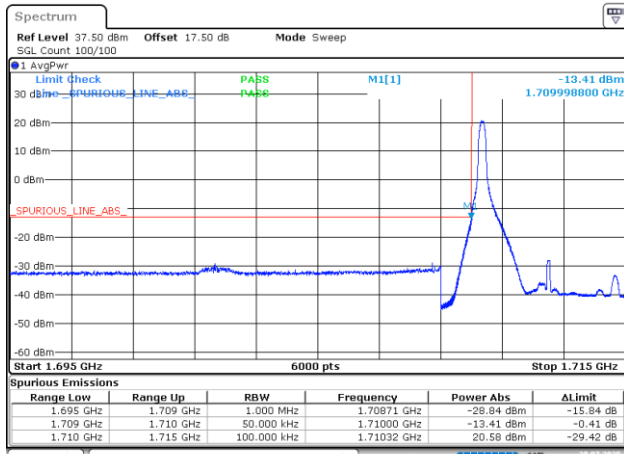
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Date: 21.JUL.2025 09:31:02

5MHz\_Low\_QPSK\_25@0



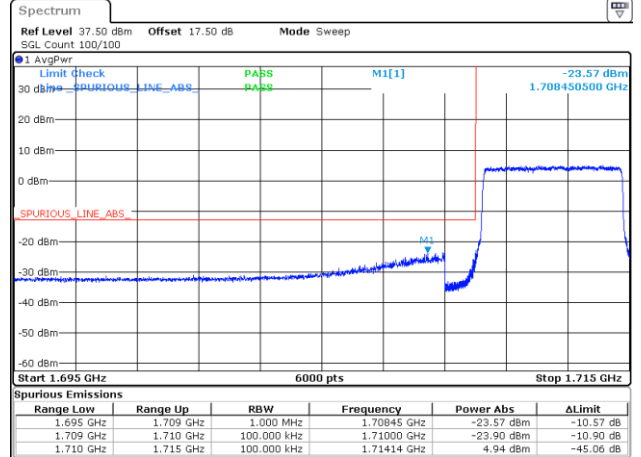
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5MHz\_Low\_16QAM\_1@0



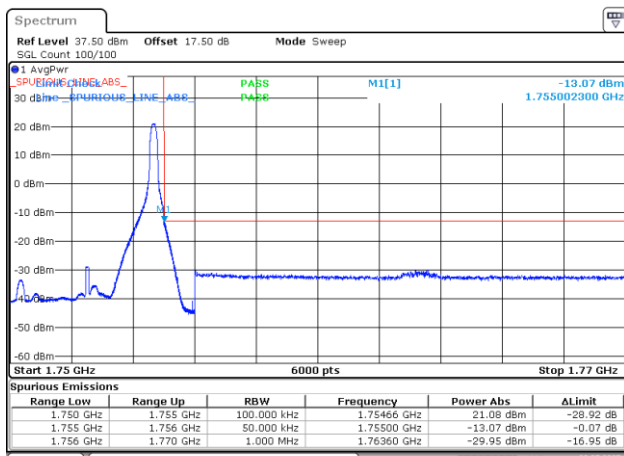
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Date: 20.JUL.2025 14:45:49

5MHz\_Low\_16QAM\_25@0



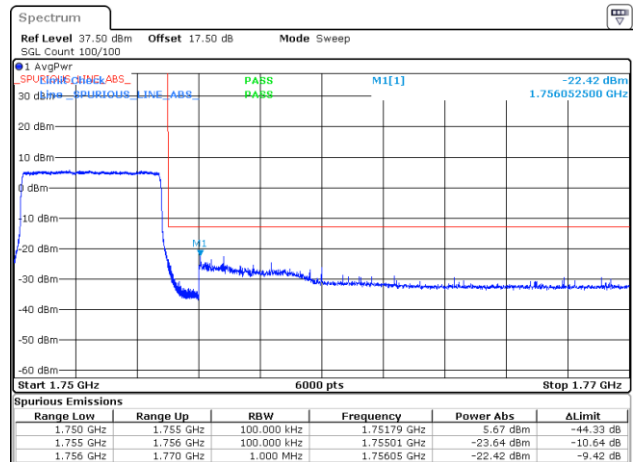
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5MHz\_High\_QPSK\_1@24



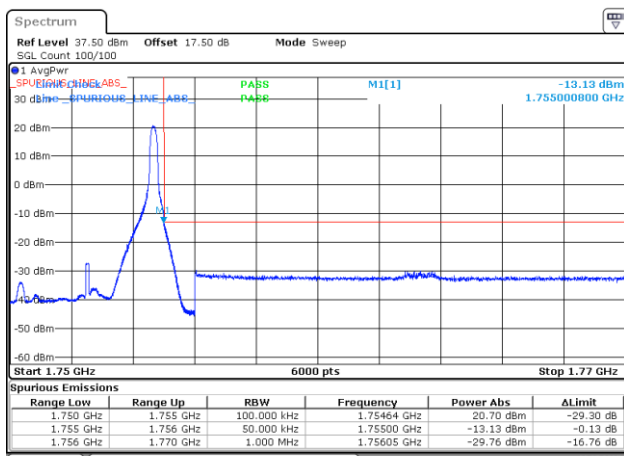
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Date: 20.JUL.2025 14:47:35

5MHz\_High\_QPSK\_25@0



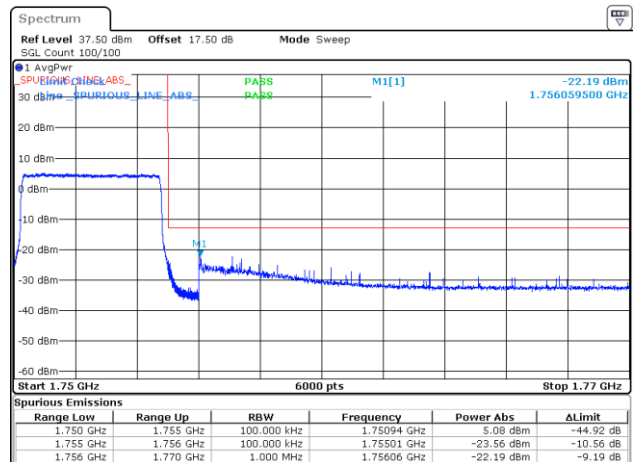
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5MHz\_High\_16QAM\_1@24



ProjectNo.:2502V28134E-RF Tester:Loge Long  
Date: 20.JUL.2025 14:52:22

5MHz\_High\_16QAM\_25@0



ProjectNo.:2502V28134E-RF Tester:Loge Long  
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